Unit: mm

TOSHIBA Field Effect Transistor Silicon P Channel MOS Type (π-MOSV)

2SJ407

Chopper Regulator, DC-DC Converter and Motor Drive Applications

• Low drain–source ON resistance : RDS (ON) = 0.8Ω (typ.)

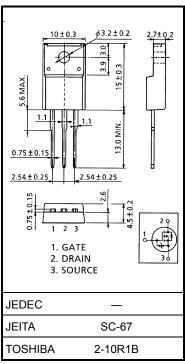
• High forward transfer admittance $: |Y_{fs}| = 4.0 \text{ S (typ.)}$

• Low leakage current $: I_{DSS} = -100 \mu A \text{ (max) (V}_{DS} = -200 \text{ V)}$

• Enhancement mode : $V_{th} = -1.5 \sim -3.5 \text{ V (V}_{DS} = -10 \text{ V, I}_{D} = -1 \text{ mA)}$

Absolute Maximum Ratings (Ta = 25°C)

Characteri	stics	Symbol	Rating	Unit	
Drain-source voltage		V _{DSS}	-200	V	
Drain-gate voltage (R _{GS} = 20 kΩ)		V_{DGR}	-200	V	
Gate-source voltage		V _{GSS}	±20	V	
Drain current	DC (Note 1)	I _D	-5	Α	
	Pulse(Note 1)	I _{DP}	-20	Α	
Drain power dissipatio	n (Tc = 25°C)	P_{D}	30	W	
Single pulse avalanche energy (Note 2)		EAS	195	mJ	
Avalanche current		I _{AR}	-5	А	
Repetitive avalenche energy (Note 3)		E _{AR}	3.0	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature r	ange	T _{stg}	-55~150	°C	



Weight: 1.9 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	4.16	°C/W
Thermal resistance, channel to ambient	R _{th (ch-a)}	62.5	°C/W

Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2: V_{DD} = -50 V, T_{ch} = 25°C (initial), L = 12.6 mH, R_{G} = 25 Ω , I_{AR} = -5 A

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device.

Please handle with caution.

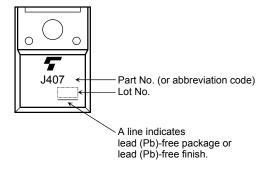
Electrical Characteristics (Ta = 25°C)

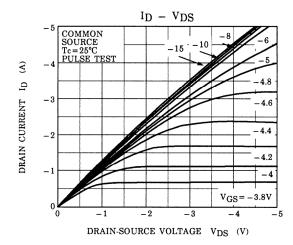
Charac	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	ırrent	I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V	_	_	±10	μΑ
Drain cut-off cu	rrent	I _{DSS}	V _{DS} = -200 V, V _{GS} = 0 V	_	_	-100	μA
Drain-source br	eakdown voltage	V (BR) DSS	I_D = -10 mA, V_{GS} = 0 V	-200	_	_	V
Gate threshold v	oltage/	V_{th}	V _{DS} = -10 V, I _D = -1 mA	-1.5	_	-3.5	V
Drain-source O	N resistance	R _{DS} (ON)	V _{GS} = -10 V, I _D = -2.5 A	_	0.8	1.0	Ω
Forward transfe	r admittance	Y _{fs}	V _{DS} = -10 V, I _D = -2.5 A	2.0	4.0	_	S
Input capacitano	ce	C _{iss}		_	800	_	
Reverse transfe	verse transfer capacitance C_{rss} $V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		_	80	_	pF	
Output capacita	out capacitance C _{oss}		_	270	_		
Rise time Turn-on time Fall time Turn-off time	Rise time	t _r	$V_{GS} = \begin{array}{c} 0V \\ -10V \\ \hline \end{array}$ $V_{GS} = \begin{array}{c} 0V \\ -10V \\ \hline \end{array}$ V_{OUT} $R_{L} = \begin{array}{c} 40\Omega \\ \end{array}$	-	15	_	ns
	Turn-on time	t _{on}		-	30	_	
	Fall time	t _f	V _{DD} = −100V	_	6	_	113
	Turn-off time	t _{off}	Duty $\leq 1\%$, $t_{\rm W} = 10 \mu \rm s$	_	65	_	
Total gate charge (Gate-source plus gate-drain)		Qg		_	20	_	
Gate-source charge		Q _{gs}	$V_{DD} \approx -160 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -5 \text{ A}$		13	_	nC
Gate-drain ("miller") charge		Q_{gd}			7	_	

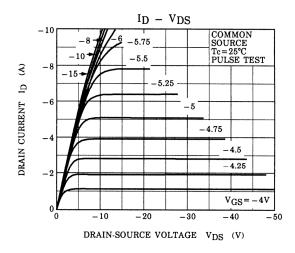
Source-Drain Ratings and Characteristics (Ta = 25°C)

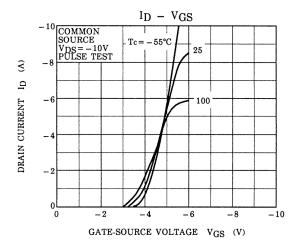
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	_	_	_	-5	Α
Pulse drain reverse current (Note 1)	I _{DRP}	_	ı	ı	-20	Α
Forward voltage (diode)	V_{DSF}	$I_{DR} = -5 \text{ A}, V_{GS} = 0 \text{ V}$			2.0	V
Reverse recovery time	t _{rr}	I _{DR} = -5 A, V _{GS} = 0 V	1	210		ns
Reverse recovery charge	Qrr	dl _{DR} / dt = 100 A / μs	-	1.2	_	μC

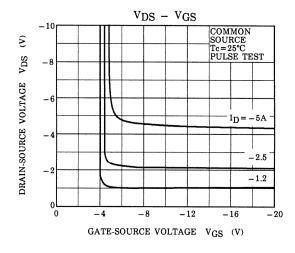
Marking

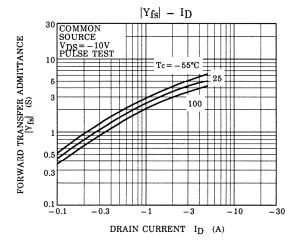


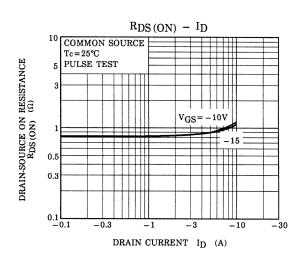


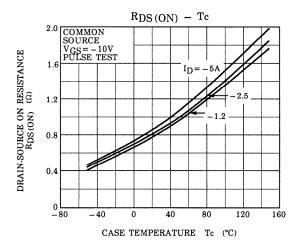


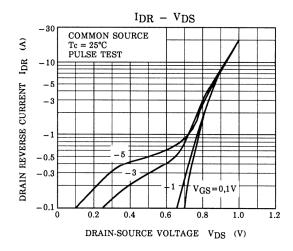


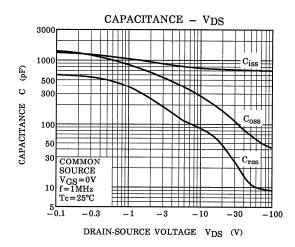


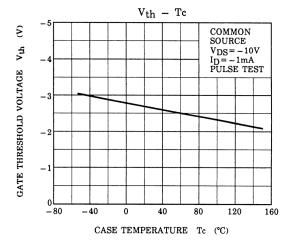


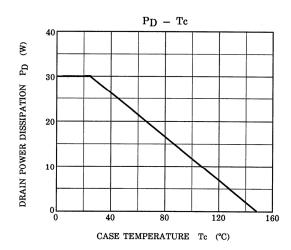


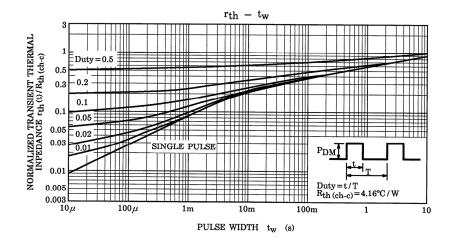


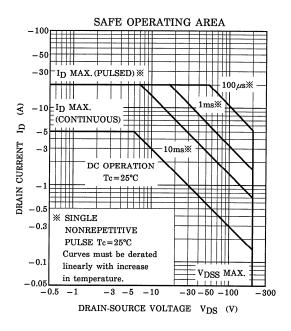


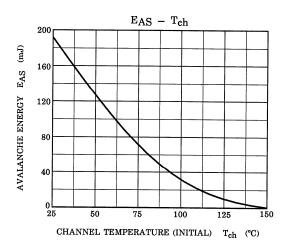


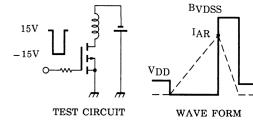












$$\begin{array}{ll} R_G\!=\!25\Omega \\ V_{DD}\!=\!-50V,\; L\!=\!12.6mH \end{array} \quad E_{AS}\!=\!\frac{1}{2}\cdot L\cdot I^2\cdot (\frac{B_{VDSS}}{B_{VDSS}\!-\!V_{DD}})$$

 v_{DS}

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20070701-EN

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